

**Search Notes**

Application/Control No.

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Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

MOTOYAMA, HAJIME

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	129-130, 232-234, 241, 247	9/30/2005	HP
	248		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	9/23/2005	HP
EAST Text Search	9/30/2005	HP